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#16/Rep.  
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Hayes

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of Applicants:

Beaman et al.

Serial No.: 09/251,988

Filed: February 17, 1999

Date: March 12, 2002

Group Art Unit: 2829

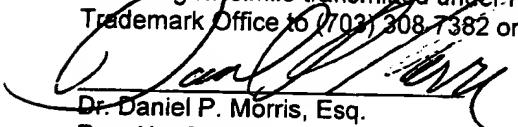
Examiner: J. M. Hollington

Docket No.: YO999-088

For: STRUCTURAL DESIGN AND PROCESSES TO CONTROL PROBE  
POSITION ACCURACY IN A WAFER TEST PROBE ASSEMBLYAssistant Commissioner for Patents  
Washington, D. C. 20231

## CERTIFICATE OF FACSIMILE TRANSMISSION

I hereby certify that this Amendment (3 pages) and Attached Figures 1-31 (19 pages) are being facsimile transmitted under Rule 37 CFR 1.61(d) to the U.S. Patent and Trademark Office to (703) 308-7382 on March 12, 2002.

  
Dr. Daniel P. Morris, Esq.  
Reg. No. 32,053

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AMENDMENT

In response to Office Action dated November 21, 2001, plus consider the following:

## REMARKS

Reconsideration is respectfully requested in view of any changes to the claims and the remarks herein. Please contact the undersigned to conduct a telephone interview in accordance with MPEP 713.01 to resolve any remaining requirements and/or issues prior to sending another Office Action. Relevant portions of MPEP 713.01 are included on the signature page of this amendment.

Claims 1-27 and 41-47 have been rejected under 35 USC 102(b) as anticipated by Beaman et al. (US 5,371,654). Applicant respectfully disagrees. The present application is a CIP of US 6,300,780 which is a divisional of US 5,821,763 which is a

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